## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

re patent application of

Docket No.: FIS920030185US

D. Chidambarrao, et al.

Serial No.: 10/605,167

Group Art Unit: 2282

Filed: September 12, 2003

Examiner: Pamela Perkins

For:

MOSFET PERFORMANCE IMPROVEMENT USING DEFORMATION IN SOI

STRUCTURE

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Sir:

Under the provisions of 37 CFR §1.97 through §1.99 and pursuant to applicant's duty of disclosure under 37 CFR §1.56, applicant respectfully brings the following documents, listed on the attached form PTO-1449, to the attention of the Examiner in charge of the above-identified application. A copy of the cited documents is enclosed for the convenience of the Examiner.

This citation does not constitute an admission that the references are relevant or material to the claims. They are only cited as constituting related art of which the applicant is aware.

It is respectfully requested that the listed references be considered by the Examiner and formally made of record in this application.

Please charge any deficiencies in fees and credit any overpayment of fees to Attorney's deposit account no. 23-1951 (McGuireWoods LLP).

Respectfully submitted,

Andrew M. Calderon

Reg. No. 38,093

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| Supplemental Form PTO-1449 (Modified)  |   |               |                                    | y Docket No.:<br>030185US1            | Serial No.:<br>10/605,167 |                |                            |                |         |       |              |
|--|---|---------------|------------------------------------|---------------------------------------|---------------------------|----------------|----------------------------|----------------|---------|-------|--------------|
| LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary) Page 1 of 1 |   |               | Applicant: D. Chidambarrao, et al. |                                       |                           |                |                            |                |         |       |              |
|  |   |               | Filing Date:<br>September 12, 2003 |                                       |                           | Group:<br>2822 |                            |                |         |       |              |
| REFERENCE DESI   | IGNATION  | U.S. P.       | ATENT                              | DOCUMENTS                             |                           |                |                            |                |         |       |              |
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